

# Radiation length ( $X/X_0$ ) imaging with high resolution telescopes

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# Motivation for spatially resolved $X/X_0$ measurements

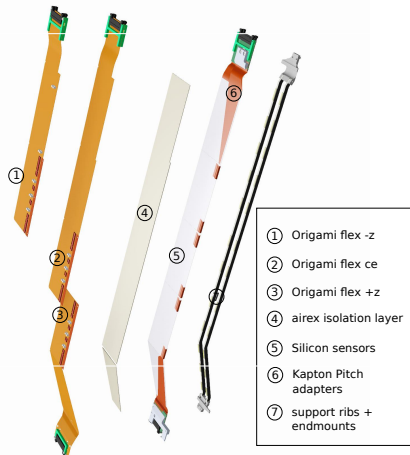
## Survey of complex material distributions

- Low material budget is an essential part of modern vertex detector development
- High level of integration (readout, cooling, electronics) leads to a complex module design
- Precise vertex reconstruction →  $X/X_0$  distribution of vertex detector must be known well

→ Spatially resolved measurements based on multiple scattering to cross-check the detector model

## Example: Belle II Si strip layer

### SVD ladder (layer6)



# Motivation for spatially resolved $X/X_0$ measurements

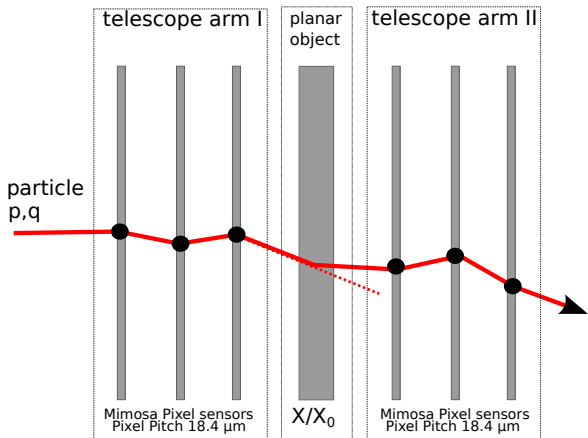
## Measurement of Radiation length constant $X_0$

- Components with unknown radiation length often used in detector systems
- Glues, thermally conductive materials, metal compounds, capacitors etc.
- $X/X_0$  Measurement of a sample with a known thickness  $X$  allows estimation of radiation length constant  $X_0$

→ Possibility to create a database with  $X_0$  values for relevant materials

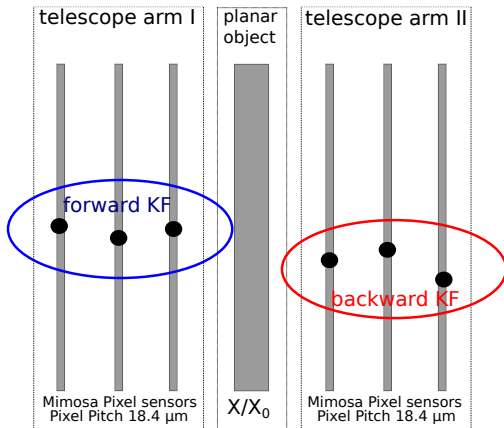
# Reconstruction of multiple scattering angles

- Planar object centered in high resolution telescope
- Multi GeV particle beam  $\rightarrow$  telescope sensor hits



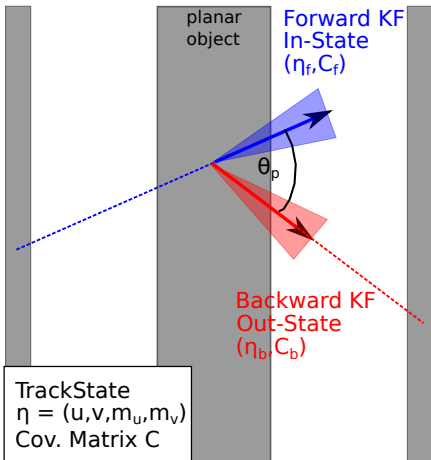
# Reconstruction of multiple scattering angles

- Planar object centered in high resolution telescope
- Multi GeV particle beam  $\rightarrow$  telescope sensor hits
- Forward- backward Kalman Filter (KF) pair on hits



# Reconstruction of multiple scattering angles

- Planar object centered in high resolution telescope
- Multi GeV particle beam  $\rightarrow$  telescope sensor hits
- Forward- backward Kalman Filter (KF) pair on hits
- $\theta_p$  calculated from track slopes ( $m_u, m_v$ )
- Intersection pos. ( $u, v$ ) of particle from track states
- angle error  $\sigma_{\text{err}}$  from error propagation



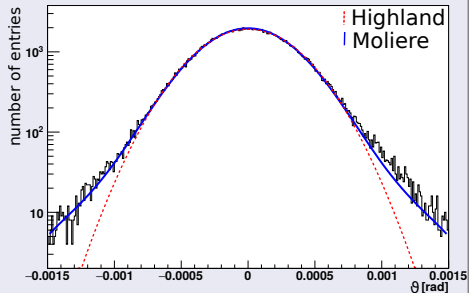
# $X/X_0$ Measurements

## Basic idea

- Reconstruct kink angle distributions in pixels on central plane
- Define u-v bins at the scattering plane and fill histograms with scatter kinks

## First part: Multiple scattering distribution $f_{\text{scatt.}}$

- Fit angle distribution with a function  $f_{\text{reco}}$ , which is based on the Moliere or the Highland model of multiple scattering
- Highland: Gaussian dist., no description of tails
- Moliere: Describes whole distribution



# $X/X_0$ Measurements

## Basic idea

- Reconstruct kink angle distributions in pixels on central plane
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## Calibration with dedicated calibration target

- Fit function  $f_{\text{reco}}$  given by

$$\begin{aligned}
 f_{\text{reco}} &= f_{\text{scatt.}}(\theta, X/X_0, p, \kappa) \otimes f_{\text{err}}(\theta, \lambda, \sigma_{\text{err}}) \\
 &= f_{\text{scatt.}}(\theta, X/X_0, p, \kappa) \otimes \frac{1}{\lambda \sigma_{\text{err}} \sqrt{2\pi}} \exp\left(-\frac{1}{2} \left(\frac{\theta}{\lambda \sigma_{\text{err}}}\right)^2\right)
 \end{aligned}$$

- calibration factor  $\lambda$  corrects a systematic shift of the Kalman filter predicted angular resolution
- $\kappa$  corrects a global scale error of the kink angle distribution width, caused by a small mistake in the telescope length and/or the beam energy



# $X/X_0$ Measurements

## Basic idea

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- Target with well known material profile allows  $\lambda$  and  $\kappa$  calibration
- Find parameters by simultaneous fit of reconstructed angle distributions

# $X/X_0$ Measurements

## Basic idea

- Reconstruct kink angle distributions in pixels on central plane
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$$\begin{aligned} f_{\text{reco}} &= f_{\text{scatt.}}(\theta, X/X_0, \rho, \kappa) \otimes f_{\text{err}}(\theta, \lambda, \sigma_{\text{err}}) \\ &= f_{\text{scatt.}}(\theta, X/X_0, \rho, \kappa) \otimes \frac{1}{\lambda \sigma_{\text{err}} \sqrt{2\pi}} \exp\left(-\frac{1}{2} \left(\frac{\theta}{\lambda \sigma_{\text{err}}}\right)^2\right) \end{aligned}$$

- Target with well known material profile allows  $\lambda$  and  $\kappa$  calibration
- Find parameters by simultaneous fit of reconstructed angle distributions

## Second step: Measurement on materials

- Use optimal calibration parameters in  $f_{\text{reco}}$  to fit  $X/X_0$

# How to conduct radiation length measurements?

- 1 Preparation and experimental setup
  - 2 Telescope alignment and Cluster calibration
  - 3 Angle resolution calibration
  - 4 Measurements
- More information on the  $X/X_0$  measurements can be found at <https://doi.org/10.1016/j.nima.2016.06.086>
  - The software that was used to analyse the beam test data and produce the results in this presentation can be found at <https://bitbucket.org/BenjaminSchwenker/tbsw>

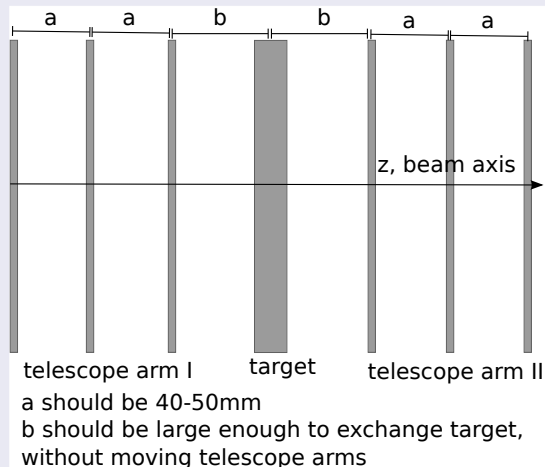
# How to conduct radiation length measurements?

- 1 Preparation and experimental setup
- 2 Telescope alignment and Cluster calibration
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- 4 Measurements

# Preparation and experimental setup

- M26 distance of 40 to 50 mm is a compromise between good spatial resolution and scattering angle resolution  $\sigma_{\text{err}}$
- space between telescope arms should be large enough to exchange measurement targets without moving the telescope arms
- z positions of M26 and target should be measured accurately ( $\sigma_z < 1.0$  mm)
- Good idea to also measure distance between first and last M26

## Good Telescope setup for $X/X_0$ measurements



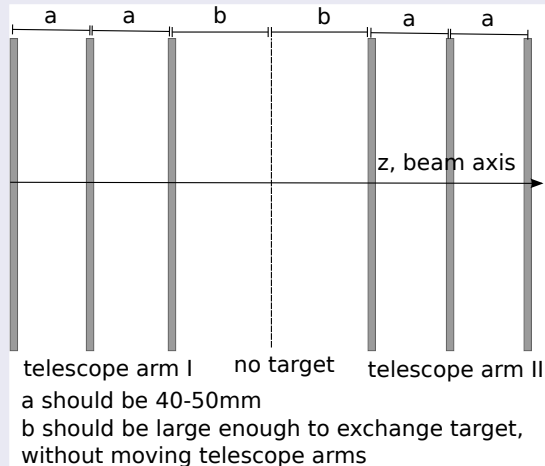
# How to conduct radiation length measurements?

- 1 Preparation and experimental setup
- 2 Telescope alignment and Cluster calibration
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- 4 Measurements

# Telescope alignment and Cluster calibration

- Remove target during telescope alignment → air run
- Size of the M26 clusters during the telescope calibration important
- Tune M26 threshold in such a way that the ratio of 1 to 2 pixel size clusters is 1:1 → good resolution of reconstructed M26 hits
- Additionally: M26 occupancy shouldn't be too large ( $< 10$  hits/event per sensor)

## Telescope setup during alignment



# How to conduct radiation length measurements?

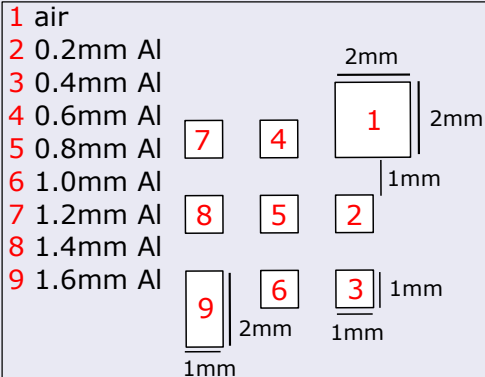
- 1 Preparation and experimental setup
- 2 Telescope alignment and Cluster calibration
- 3 **Angle resolution calibration**
- 4 Measurements



# Angle resolution calibration

- Use calibration target with well known material profiles for the calibration
- Calibration factors  $\lambda$  and  $\kappa$  should be close to 1.0  $\rightarrow$  systematic errors visible in calibration measurement

## Example of a calibration target

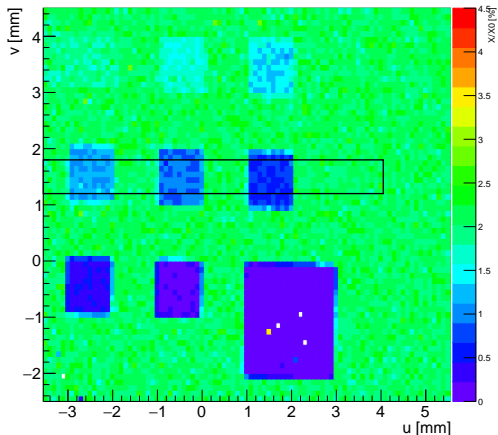


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$X/X_0$  image of a calibration target

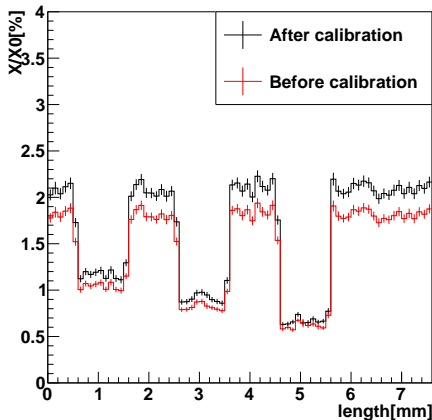
x0\_image



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## Comparison of radiation length profiles



Here:  $\lambda = 1.085 \pm 0.003$ ,  $\kappa = 0.915 \pm 0.02$

# How to conduct radiation length measurements?

- 1 Preparation and experimental setup
- 2 Telescope alignment and Cluster calibration
- 3 Angle resolution calibration
- 4 **Measurements**

# Measurements

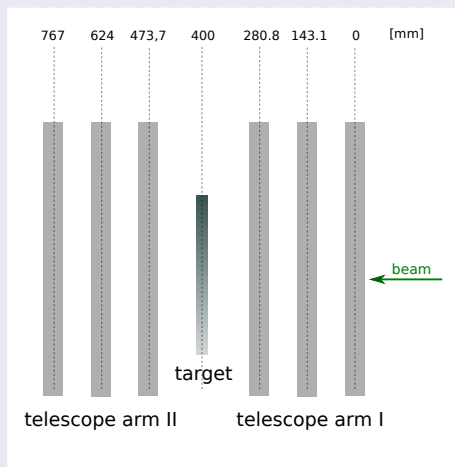
- The minimal pixel size of the radiation length images depends on the total number of tracks in the beam spot region
  - At least 1000 - 2000 tracks per pixel to ensure a stable fit
  - This means for an image with  $100 \times 100 \mu\text{m}$  pixels and a beamspot size of  $10 \times 20 \text{mm}$  (M26 acceptance) at least 20 mio tracks are needed
  - Assuming an event rate of 1 kHz and 1 track per event (higher values are possible) the measurement would take approximately 6 hours
  - $\sigma_{\text{MSC}} \propto 1/p$  therefore a low beam energy should be used during measurements
- 
- You will have to repeat the alignment and calibration steps everytime you change the telescope geometry or the beam energy
  - air run  $\rightarrow$  calibration run  $\rightarrow$  measurement

# $X/X_0$ measurements on different glue samples

## Overview

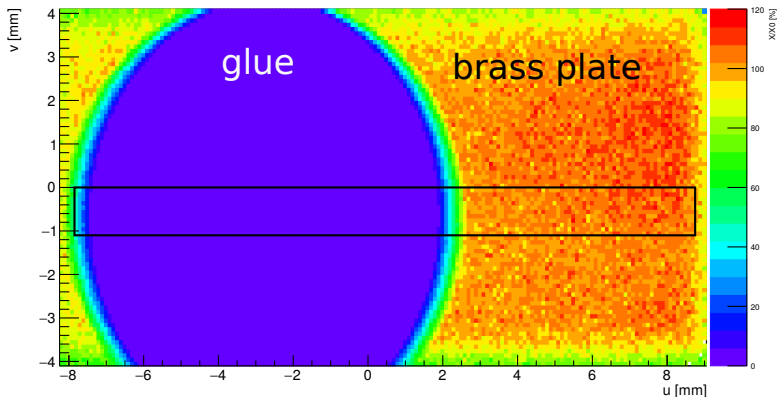
- Data from a DESY TB in 2016
- 4 glue samples (A-D)
- glue A-C:  $X \approx 10\text{mm}$  embedded in brass plate
- glue D: Conductive silver glue with  $X = 1.83\text{mm}$
- approximately 8 mio tracks per glue sample

## Telescope setup



# $X_0$ measurement of different glues

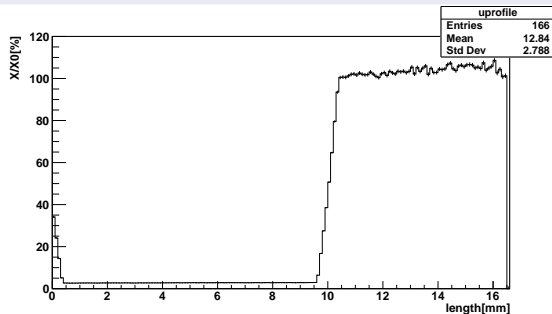
X0 image (4.6 GeV,  $100 \mu\text{m}^2$  pixels)



Radiation length image of glue B and the brass plate

# $X_0$ measurement of different glues

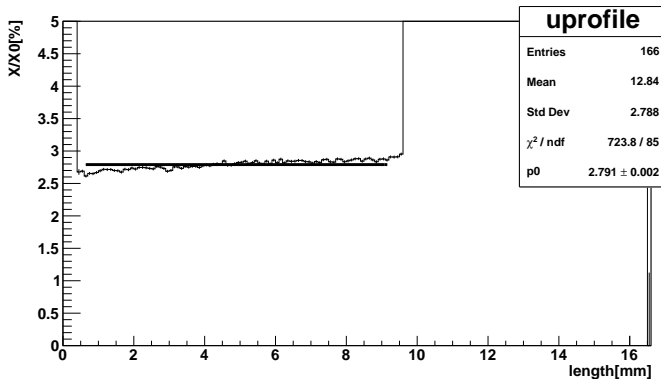
## Radiation length profile





# $X_0$ measurement of different glues

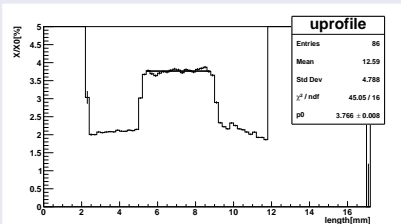
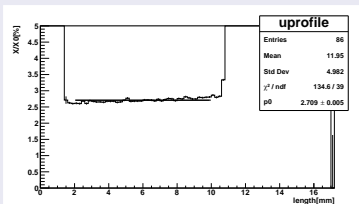
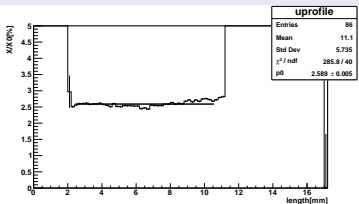
Radiation length profile: Zoom in and fit of  $X/X_0$  in glue area



Fit yields  $X/X_0(10.17\text{mm of glueB}) = (2.8 \pm 0.1)\%$ , Visible gradient in profile: Use 0.1% error  $\rightarrow X_0(\text{glue B}) = (360 \pm 20)$  mm

# $X_0$ measurement of different glues

## Measurement of other glues



# $X_0$ measurement of different glues

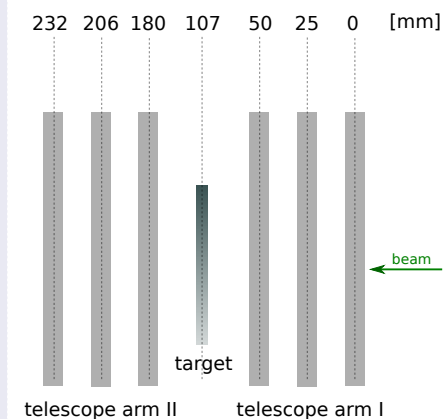
## Summary of glue measurements

- $X_0(\text{glue A})=(400\pm 20)$  mm
- $X_0(\text{glue A})=(360\pm 20)$  mm
- $X_0(\text{glue C})=(370\pm 20)$  mm
- $X_0(\text{glue D})=(48\pm 2)$  mm
- The glues A-C are expected to have a radiation length constant larger than 320 mm

# $X/X_0$ measurements on ITk dummy module

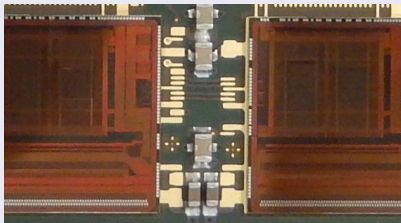
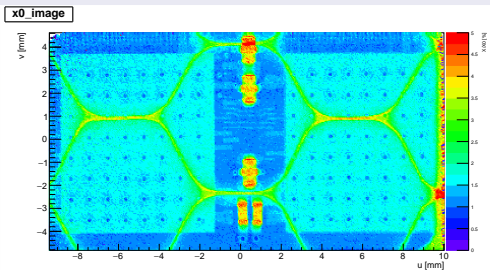
- Data from DESY TB in August 16
- ITk dummy module on a support structure with carbon fiber honeycomb structure
- beam energy 3GeV
- 140 mio tracks, image with 50  $\mu\text{m}$  pixels

## Telescope setup



$X/X_0$  image of ITk dummy module with support structure

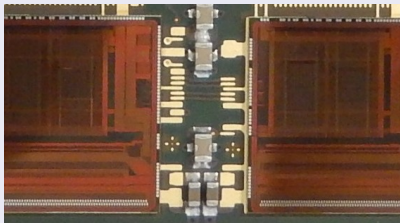
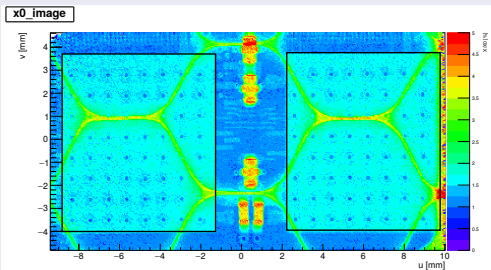
photograph

X0 image (3GeV, 50  $\mu\text{m}^2$  pixels)

visible structures

$X/X_0$  image of ITk dummy module with support structure

photograph

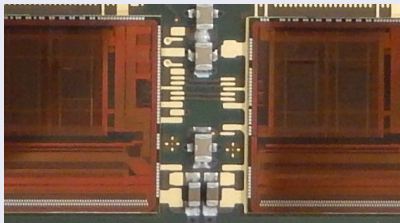
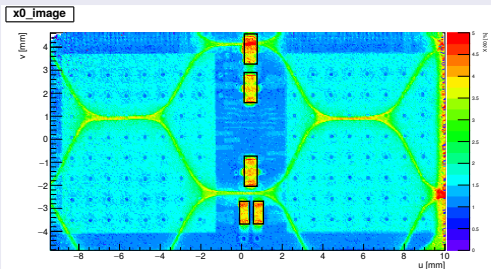
X0 image (3GeV, 50  $\mu\text{m}^2$  pixels)

visible structures

read-out chips,

$X/X_0$  image of ITk dummy module with support structure

photograph

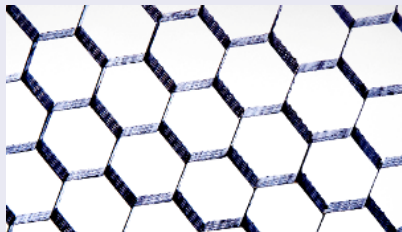
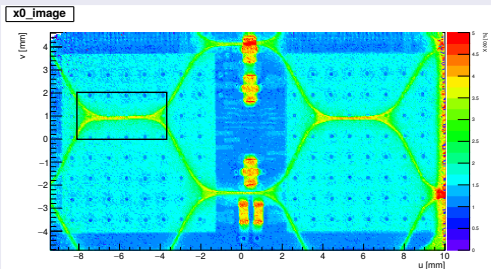
X0 image (3GeV,  $50 \mu\text{m}^2$  pixels)

visible structures

read-out chips, capacitor arrays with solder,

$X/X_0$  image of ITk dummy module with support structure

honeycomb structure

 $X_0$  image (3GeV,  $50 \mu\text{m}^2$  pixels)

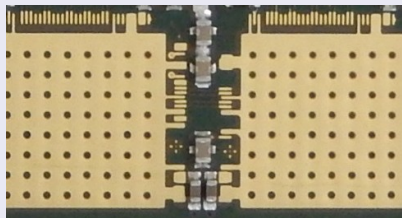
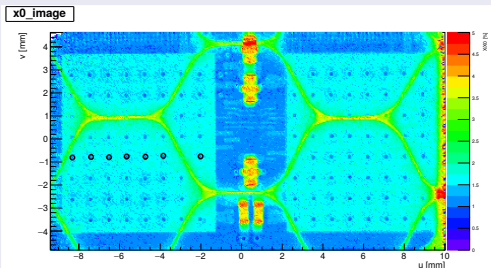
## visible structures

read-out chips, capacitor arrays with solder, honeycomb carbon fibers in support structure and glue halo,



$X/X_0$  image of ITk dummy module with support structure

photograph

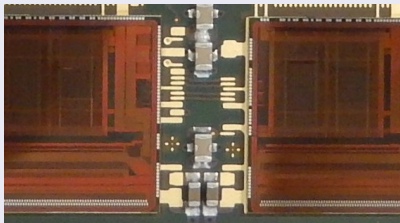
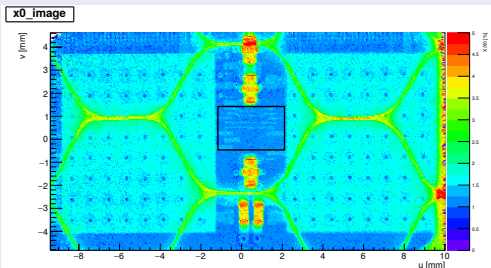
X0 image (3GeV, 50  $\mu\text{m}^2$  pixels)

## visible structures

read-out chips, capacitor arrays with solder, honeycomb carbon fibers in support structure and glue halo, vias,

$X/X_0$  image of ITk dummy module with support structure

photograph

X0 image (3GeV,  $50 \mu\text{m}^2$  pixels)

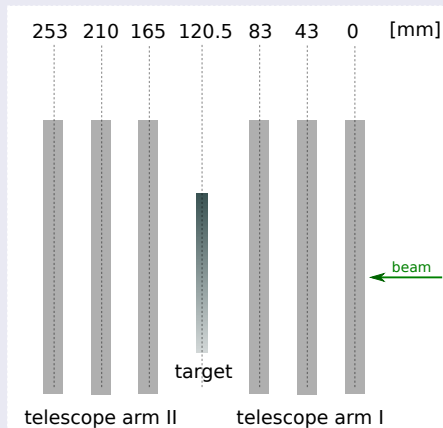
## visible structures

read-out chips, capacitor arrays with solder, honeycomb carbon fibers in support structure and glue halo, vias, bond pads and metal traces

# $X/X_0$ measurements on a Belle II pixel dummy module

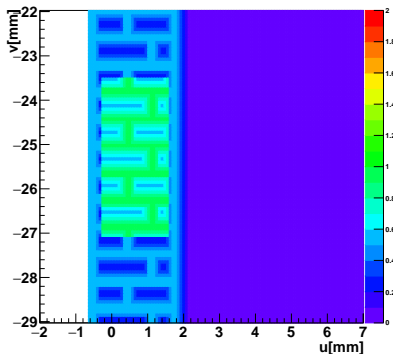
- Data from DESY TB in March 15
- Mechanical sample of a Belle II pixel module
- beam energy 4 and 2 GeV
- 50 and 45 mio tracks respectively, image with 75  $\mu\text{m}$  pixels

## Telescope setup



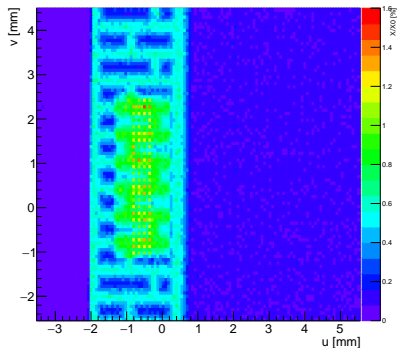
# $X/X_0$ image of Belle II pixel dummy module

## Geant 4 Detector model



## $X_0$ image (2GeV, $75 \mu\text{m}^2$ pixels)

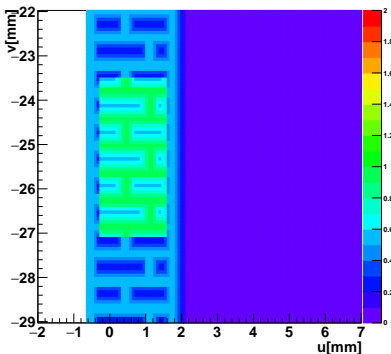
### x0\_image



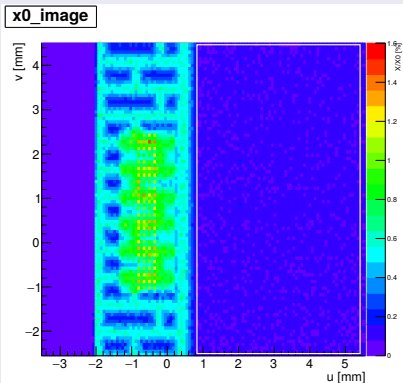
visible structures

# $X/X_0$ image of Belle II pixel dummy module

## Geant 4 Detector model



## $X_0$ image (2GeV, $75 \mu\text{m}^2$ pixels)

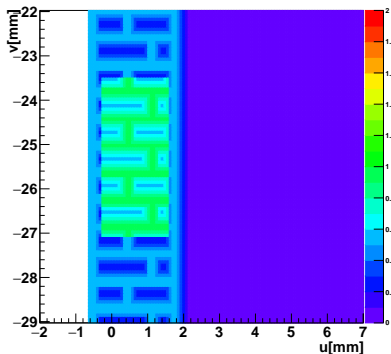


visible structures

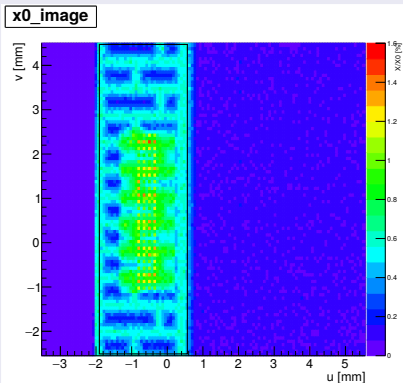
sensitive area,

# $X/X_0$ image of Belle II pixel dummy module

## Geant 4 Detector model



## $X_0$ image (2GeV, $75 \mu\text{m}^2$ pixels)

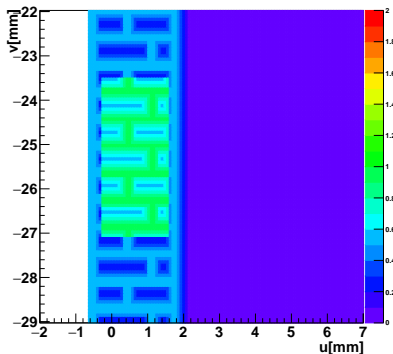


visible structures

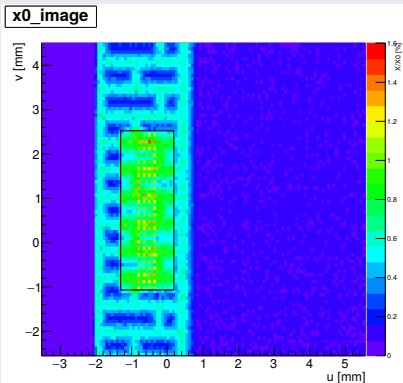
sensitive area, balcony with groove etchings,

# $X/X_0$ image of Belle II pixel dummy module

## Geant 4 Detector model



## $X_0$ image (2GeV, $75 \mu\text{m}^2$ pixels)

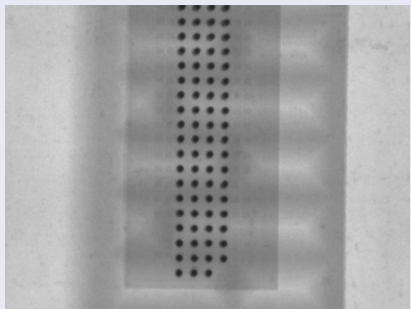


visible structures

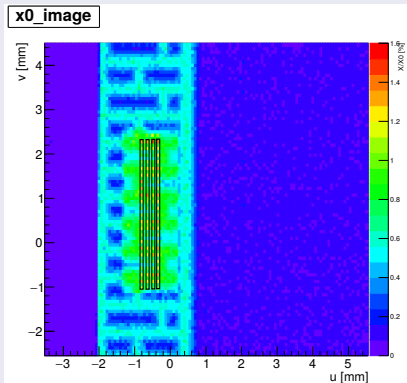
sensitive area, balcony with groove etchings, ASIC

# $X/X_0$ image of Belle II pixel dummy module

## X-ray of ASIC and bump bonds



## $X_0$ image (2GeV, $75 \mu\text{m}^2$ pixels)



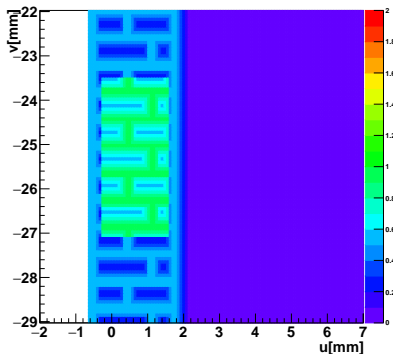
visible structures

sensitive area, balcony with groove etchings, ASIC bump bonds,

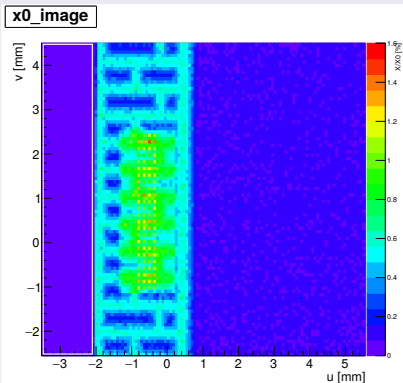


# $X/X_0$ image of Belle II pixel dummy module

## Geant 4 Detector model



## $X_0$ image (2GeV, $75 \mu\text{m}^2$ pixels)

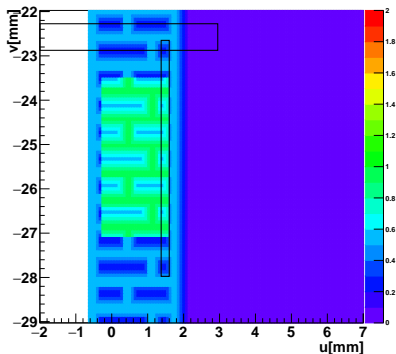


visible structures

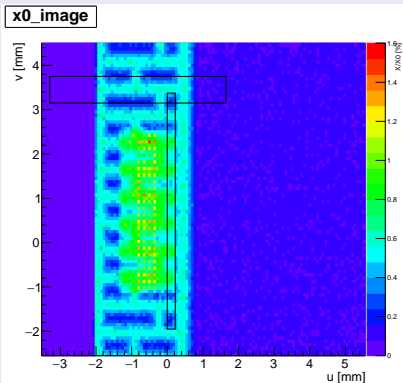
sensitive area, balcony with groove etchings, ASIC bump bonds, and air

# $X/X_0$ image of Belle II pixel dummy module II

## Geant 4 Detector model



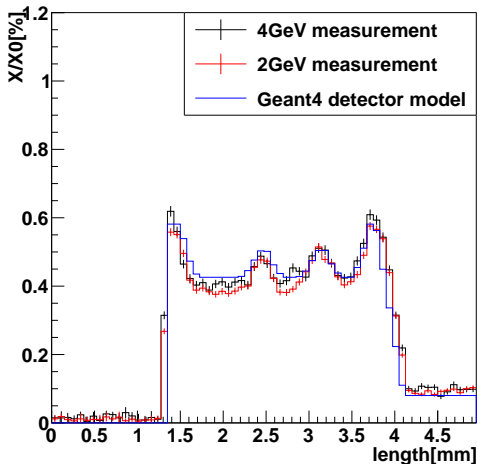
## $X_0$ image (2GeV, 75 $\mu\text{m}^2$ pixels)



Comparison of radiation length profiles between GEANT4 detector model and  $X/X_0$  measurements

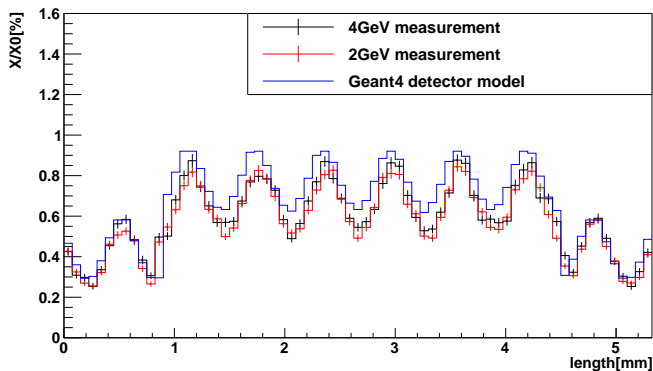
# $X/X_0$ image of Belle II pixel dummy module II

u profile across the balcony



# $X/X_0$ image of Belle II pixel dummy module II

## $\nu$ profile along the balcony



# Conclusion and Outlook

## Acknowledgment and disclaimer

- Measurements presented here were conducted at DESY with the DURANTA and DATURA beam telescopes
- The research leading to these results has received funding from the European Commission under the FP7 Research Infrastructures project AIDA, grant agreement no. 262025
- The information herein only reflects the views of its authors and not those of the European Commission and no warranty expressed or implied is made with regard to such information or its use

# Conclusion and Outlook

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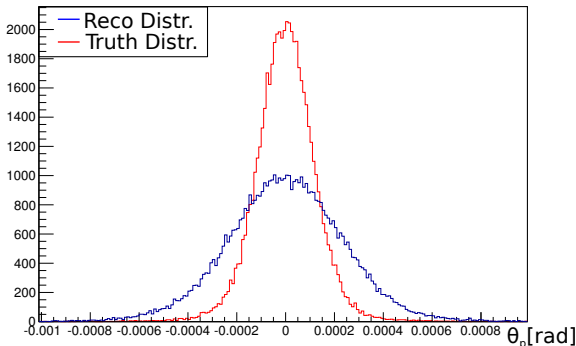
- Spatially resolved radiation length measurements can be used to cross check GEANT4 and CAD detector models
- Small structures like 50  $\mu\text{m}$  diameter bump bonds can be resolved
- $X/X_0$  resolution good enough to measure 75  $\mu\text{m}$  of silicon ( $X/X_0 \approx 0.08\%$ )
- Additionally the material constant  $X_0$  of previously unknown detector components like for example glue can be determined
- Measurements can easily be conducted, the only requirements are:
  - A high-resolution telescopes, which are for example present at the DESY test beam facilities
  - A calibration target, for example a single or multiple aluminium plates with different thicknesses
  - A few hours of beam time

Thank you!

# Backup Slides



# Example of a reconstructed angle distribution



## Composition of the Reco Distribution

Reconstructed MSC angle distribution is a convolution between the pure MSC angle distribution and a Gaussian noise distribution caused by the reconstruction errors

# MSC models

## Highland (HL) model

$$\sigma = \frac{0.0136 \cdot q[e]}{\beta \cdot p [\text{GeV}]} \cdot \sqrt{\frac{X}{X_0}} \left( 1 + 0.0038 \ln \left( \frac{X}{X_0} \right) \right)$$

V. L. Highland, *Some practical remarks on multiple scattering*, Nuclear Instruments and Methods, 1975

## Moliere model

$$f(\theta) d\theta = \frac{1}{\chi_c \sqrt{B}} \left( \frac{2}{\sqrt{\pi}} e^{-\frac{\theta}{\chi_c \sqrt{B}}} + \frac{f_1(\theta)}{B} + \frac{f_2(\theta)}{B^2} \right) d\theta, \text{ where}$$

$$\chi_c = \frac{22.9 z Z}{p c \beta} \cdot \sqrt{\frac{\rho X}{A}}.$$

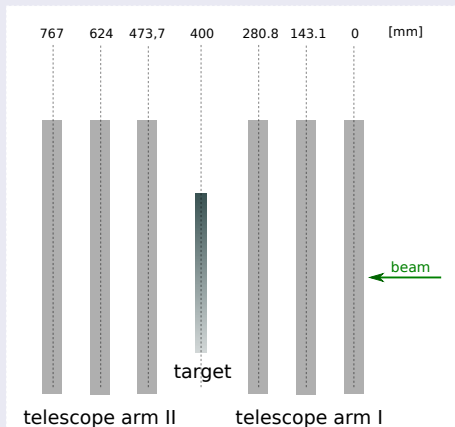
Correction terms  $f_1$  and  $f_2$ . Values can be calculated or taken from a table (see paper by Moliere).

*Moliere, Z. Naturforschg 1948*

# $X/X_0$ measurements on different glue samples

- Data from a DESY TB in 2016
- 4 glue samples (A-D)
- glue A-C:  $X \approx 10\text{mm}$  embedded in brass plate
- glueD: Conductive silver glue with  $X = 1.83\text{mm}$
- beam energy 4.6 GeV,  $\sigma_{\text{err}} = 113\ \mu\text{rad}$
- approximately 8 mio tracks per glue sample
- Calibration parameters:  
 $\lambda = 1.104 \pm 0.001$ ,  
 $\kappa = 1.040 \pm 0.002$

## Telescope setup



# $X/X_0$ measurements on ITk dummy module

- Data from DESY TB in August 16
- beam energy 3GeV
- 140 mio tracks, image with 50  $\mu\text{m}$  pixels
- nominal angle resolution  $\sigma_{\text{err}}=246 \mu\text{rad}$
- Calibration parameters:  
 $\lambda=1.040 \pm 0.001$ ,  
 $\kappa=0.915 \pm 0.001$

## Telescope setup

